



N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = 25°C
	2Ω @ V _{GS} = 10V	380mA
60V	3Ω @ V _{GS} = 5V	310mA

Description and Applications

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

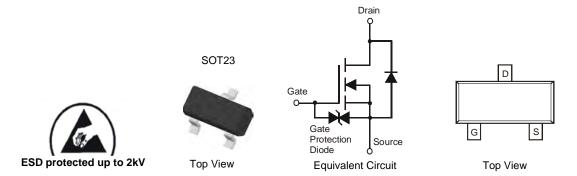
- Motor control
- Power Management Functions
- Backlighting

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Lead, Halogen and Antimony Free, RoHS Compliant "Green" Device (Notes 1 and 2)
- ESD Protected Up To 2kV
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SOT23
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Alloy 42 leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.008 grams (approximate)



Ordering Information (Note 3)

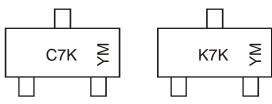
Part Number	Qualification	Case	Packaging
2N7002K-7	Commercial	SOT23	3000/Tape & Reel
2N7002KQ-7	Automotive	SOT23	3000/Tape & Reel
2N7002K-13	Commercial	SOT23	10000/Tape & Reel
2N7002KQ-13	Automotive	SOT23	10000/Tape & Reel

Notes: 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. No purposely added lead. Halogen and Antimony free.

2. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com.

3. For packaging details, go to our website at http://www.diodes.com.

Marking Information



Chengdu A/T Site Shanghai A/T Site

K = SAT (Shanghai Assembly/ Test site)C = CAT (Chengdu Assembly/ Test site)

7K= Product Type Marking Code YM = Date Code Marking

Y = Year (ex: N = 2002) M = Month (ex: 9 = September)

Date Code Key

Year	2006	2007	2008	2009	2010	2011	2012	2013	2014	2015	2016	2017
Code	Т	U	V	W	Χ	Υ	Z	Α	В	С	D	Е
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Units			
Drain-Source Voltage	V_{DSS}	60	V			
Gate-Source Voltage			V_{GSS}	±20	V	
Continuous Drain Current (Note 5) $V_{GS} = 10V$ $Steady State T_A = 25^{\circ}C$ $T_A = 70^{\circ}C$ $t < 5s T_A = 70^{\circ}C$			l _D	380 300	mA	
			Ι _D	430 340	mA	
S		$T_A = 25$ °C $T_A = 70$ °C	l _D	310 240	mA	
Continuous Drain Current (Note 5) V _{GS} = 5V	t<5s	$T_A = 25^{\circ}C$ $T_A = 70^{\circ}C$	l _D	350 270	mA	
Maximum Continuous Body Diode Forward Current	I _S	0.5	Α			
Pulsed Drain Current (10µs pulse, duty cycle = 1%) (Note 5)			I _{DM}	1.2	Α	

Thermal Characteristics @T_A = 25°C unless otherwise specified

Characteristic		Symbol	Value	Units	
Total Power Dissipation (Note 4)		P _D	370	mW	
The second Decision of Australia (Alace 4)		Б.	357	°C/W	
Thermal Resistance, Junction to Ambient (Note 4)	t<5s	$R_{\theta JA}$	292	C/VV	
Total Power Dissipation (Note 5)		P _D	540	mW	
Thermal Begintenes, Junction to Ambient (Note 5)	Steady State	D	240		
Thermal Resistance, Junction to Ambient (Note 5)	t<5s	$R_{\theta JA}$	197	°C/W	
Thermal Resistance, Junction to Case (Note 5)		$R_{\theta JC}$	91		
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to 150	°C	

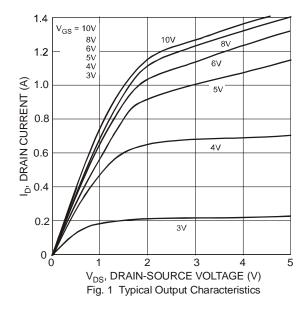
Electrical Characteristics @TA = 25°C unless otherwise specified

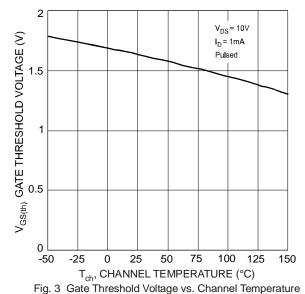
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)						
Drain-Source Breakdown Voltage	BV _{DSS}	60	_		V	$V_{GS} = 0V, I_D = 10\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1.0	μΑ	$V_{DS} = 60V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}			±10	μΑ	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V _{GS(th)}	1.0	1.6	2.5	V	$V_{DS} = 10V, I_{D} = 1mA$
Static Drain-Source On-Resistance	D (21)		_	2.0	Ω	$V_{GS} = 10V, I_D = 0.5A$
Static Drain-Source On-Nesistance	R _{DS} (ON)			3.0	22	$V_{GS} = 5V, I_D = 0.05A$
Forward Transfer Admittance	Y _{fs}	80		_	ms	$V_{DS} = 10V, I_D = 0.2A$
Diode Forward Voltage	V_{SD}		0.75	1.1	>	$V_{GS} = 0V, I_{S} = 115mA$
DYNAMIC CHARACTERISTICS (Note 7)						
Input Capacitance	C _{iss}	_	30	50	pF	N/ 05V/ V/ 0V/
Output Capacitance	Coss	_	4.2	25	pF	$V_{DS} = 25V, V_{GS} = 0V$ f = 1.0MHz
Reverse Transfer Capacitance	Crss	_	2.9	5.0	pF	1 – 1.001112
Gate Resistance	R_{g}		133		mΩ	$f = 1MHz$, $V_{GS} = 0V$, $V_{DS} = 0V$
Total Gate Charge	Qg		0.3		nC	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
Gate-Source Charge	Q_{gs}	_	0.2	_	nC	$V_{GS} = 4.5V, V_{DS} = 10V,$ $I_{D} = 250 \text{mA}$
Gate-Drain Charge	Q_{gd}		0.08	_	nC	ID = 250IIIA
Turn-On Delay Time	t _{D(on)}		3.9		ns	
Turn-On Rise Time	t _r	_	3.4		ns	$V_{DD} = 30V, V_{GS} = 10V,$
Turn-Off Delay Time	t _{D(off)}	_	15.7		ns	$R_G = 25\Omega$, $I_D = 200 \text{mA}$
Turn-Off Fall Time	t _f		9.9		ns	

Notes:

- Device mounted on FR-4 PCB, with minimum recommended pad layout
 Device mounted on 1" x 1" FR-4 PCB with high coverage 2oz. Copper, single sided.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.







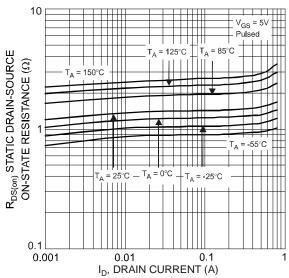
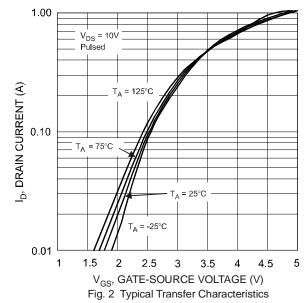


Fig. 5 Static Drain-Source On-Resistance vs. Drain Current



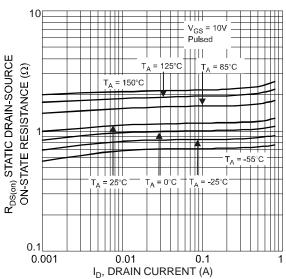


Fig. 4 Static Drain-Source On-Resistance vs. Drain Current

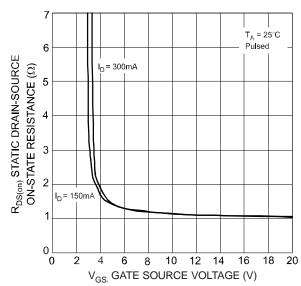


Fig. 6 Static Drain-Source On-Resistance vs. Gate-Source Voltage



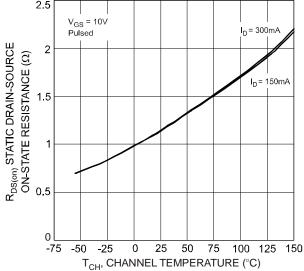


Fig. 7 Static Drain-Source On-State Resistance vs. Channel Temperature

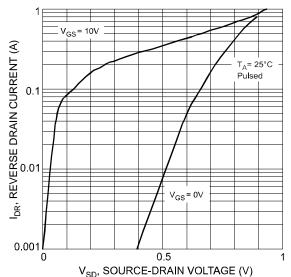
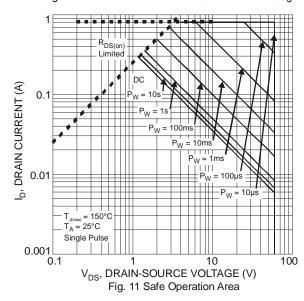
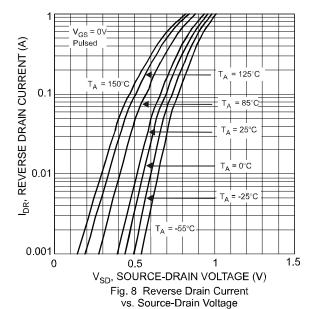


Fig. 9 Reverse Drain Current vs. Source-Drain Voltage





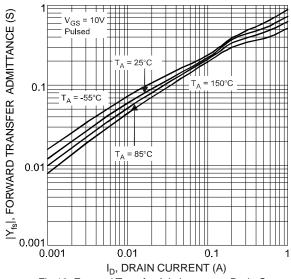


Fig. 10 Forward Transfer Admittance vs. Drain Current

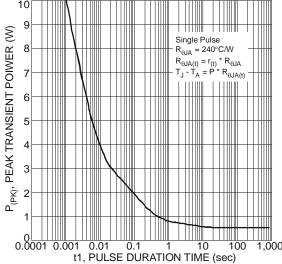
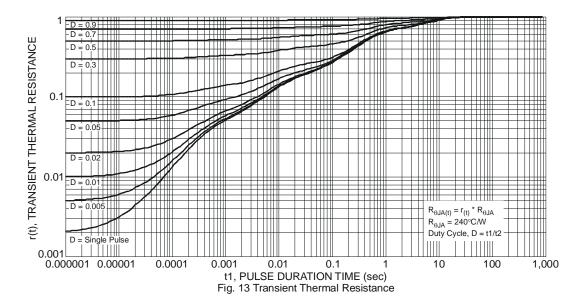
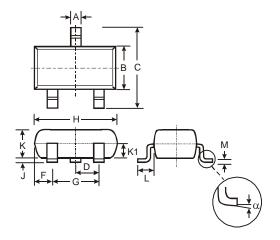


Fig. 12 Single Pulse Maximum Power Dissipation



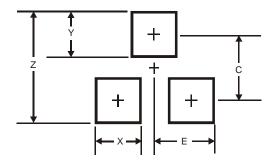


Package Outline Dimensions



SOT23								
Dim	Min	Max	Тур					
Α	0.37	0.51	0.40					
В	1.20	1.40	1.30					
С	2.30	2.50	2.40					
D	0.89	1.03	0.915					
F	0.45	0.60	0.535					
G	1.78	2.05	1.83					
Н	2.80	3.00	2.90					
J	0.013	0.10	0.05					
K	0.903	1.10	1.00					
K1	-	ı	0.400					
L	0.45	0.61	0.55					
M	0.085	0.18	0.11					
α	0°	8°	-					
All	All Dimensions in mm							

Suggested Pad Layout



Dimensions	Value (in mm)
Z	2.9
X	0.8
Υ	0.9
С	2.0
ш	1.35



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